Notice of References Cited Application/Control No. 09/841,097 Examiner Sargon N Nano Applicant(s)/Patent Under Reexamination YOSHIMURA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,442,169	08-2002	Lewis, Shawn M.	370/401
	В	US-5,974,453	10-1999	Andersen et al.	709/220
	С	US-6,393,484	05-2002	Massarani, Leonardo C.	709/227
	D	US-6,452,925	09-2002	Sistanizadeh et al.	370/352
	Е	US-6,243,379	06-2001	Veerina et al.	370/389
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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